


<b>Search Notes</b>  	<b>Application/Control No.</b>  10576055	<b>Applicant(s)/Patent Under Reexamination</b>  TANAKA ET AL.
	<b>Examiner</b>  DAVID YI	<b>Art Unit</b>  2441

SEARCHED			
Class	Subclass	Date	Examiner
709	201	1/27/09	D.Y.
709	201-203, 231	8/7/09	DY

SEARCH NOTES		
Search Notes	Date	Examiner
see patent family publication documents	1/27/09	D.Y.
consulted w/ Yemane Mesfin on PCT info	1/27/09	D.Y.
see attached EAST search history	1/27/09	D.Y.
consulted Dustin Nguyen	8/6/09	DY
consulted Quang Nguyen	8/6/09	DY
see attached EAST search history	8/7/09	DY

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/DAVID YI/  
Examiner.Art Unit 2441